

<b>Notice of References Cited</b>	Application/Control No. 10/735,654	Applicant(s)/Patent Under Reexamination LI, SHIH HSIUNG	
	Examiner Samuel J. Walk	Art Unit 2632	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,759,957 B2	07-2004	Murakami et al.	340/541
	B	US-5,438,318 A	08-1995	Latorre et al.	340/554
	C	US-6,400,265 B1	06-2002	Saylor et al.	340/531
	D	US-2003/0204384 A1	10-2003	Owechko et al.	703/1
	E	US-6,329,930 B1	12-2001	Parsadayan, Alex M.	340/933
	F	US-6,831,550 B2	12-2004	Orita et al.	340/310.01
	G	US-2003/0206100 A1	11-2003	Richman et al.	340/506
	H	US-2004/0086090 A1	05-2004	Naidoo et al.	379/037
	I	US-2004/0086093 A1	05-2004	Schranz, Paul Steven	379/037
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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